

CMOS linear image sensors

S9227 series

Video data rate: 5 MHz max., simultaneous charge integration

The S9227 series is a small CMOS linear image sensor designed for image input applications. Signal charge is integrated on all pixels simultaneously and then read out of 5 MHz. Two package styles are provided: a DIP type and a surface mount type.

Features

- Pixel pitch: 12.5 μm
 Pixel height: 250 μm
- **⇒** 512 pixels
- 5 V single power supply operation
- **■** Video data rate: 5 MHz max.
- **■** Simultaneous charge integration
- Shutter function
- High sensitivity, low dark current, low noise
- Built-in timing generator allows operation with only start and clock pulse inputs.
- Spectral response range: 400 to 1000 nm
- Two package styles are provided:
 DIP (dual inline package) type: S9227-03
 Surface mount type: S9227-04

Applications

- **→** Position detection
- **■** Image reading

Structure

| Parameter | Specification | Unit |
|----------------------------|--------------------|------|
| Number of pixels | 512 | - |
| Pixel pitch | 12.5 | μm |
| Pixel height | 250 | μm |
| Photosensitive area length | 6.4 | mm |
| Package | Ceramic | |
| Window material | Borosilicate glass | - |

- Absolute maximum ratings

| Parameter | Symbol | Condition | Value | Unit |
|------------------------------|--------|-----------------------|---|------|
| Supply voltage | Vdd | Ta=25 °C | -0.3 to +6 | V |
| Clock pulse voltage | V(CLK) | Ta=25 °C | -0.3 to +6 | V |
| Start pulse voltage | V(ST) | Ta=25 °C | -0.3 to +6 | V |
| Operating temperature | Topr | No dew condensation*1 | -5 to +85 | °C |
| Storage temperature | Tstg | No dew condensation*1 | -10 to +85 | °C |
| Reflow soldering condition*2 | Tsol | JEDEC MSL5 | Peak temperature: 240 °C, 2 times (See P.7) | - |

^{*1:} When there is a temperature difference between a product and the surrounding area in high humidity environment, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and reliability.

^{*2:} S9227-04

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

➡ Recommended terminal voltage (Ta=25 °C)

| Parameter | | Symbol | Min. | Тур. | Max. | Unit |
|---------------------|------------|--------|------------|------|------------|------|
| Supply voltage | | Vdd | 4.75 | 5 | 5.25 | V |
| Clock pulse voltage | High level | V(CLK) | Vdd - 0.25 | Vdd | Vdd + 0.25 | V |
| | Low level | | - | 0 | - | V |
| Start pulse voltage | High level | \/(CT) | Vdd - 0.25 | Vdd | Vdd + 0.25 | V |
| | Low level | V(ST) | - | 0 | - | V |

■ Electrical characteristics [Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 V]

| Parameter | Symbol | Min. | Тур. | Max. | Unit |
|-----------------------|--------|------|--------|------|-------|
| Clock pulse frequency | f(CLK) | 50 k | - | 5 M | Hz |
| Data rate | DR | - | f(CLK) | - | Hz |
| Current consumption*3 | Ic | 20 | 26 | 32 | mA |
| Conversion efficiency | CE | - | 1.6 | - | μV/e- |
| Output impedance | Zo | - | 50 | 200 | Ω |

^{*3:} f(CLK)=5 MHz

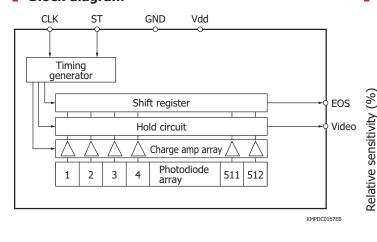
□ Electrical and optical characteristics [Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 V, f(CLK)=5 MHz]

| Parameter | Symbol | Min. | Тур. | Max. | Unit | |
|----------------------------------|---------|------|-------------|------|--------|--|
| Spectral response range | λ | | 400 to 1000 | | | |
| Peak sensitivity wavelength | λр | - | 650 | - | nm | |
| Dark current | ID | - | 10 | 100 | fA | |
| Saturation charge | Qsat | 400 | 430 | - | fC | |
| Dark output voltage*4 | VD | - | 1 | 10 | mV | |
| Saturation output voltage*5 | Vsat | 4 | 4.3 | - | V | |
| Readout noise | Nread | - | 0.45 | 2 | mV rms | |
| Output offset voltage | Voffset | - | 0.6 | 0.9 | V | |
| Photoresponse nonuniformity*6 *7 | PRNU | - | - | ±5 | % | |

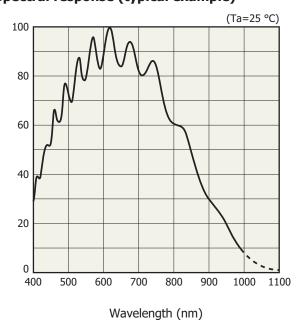
^{*4:} Integration time=10 ms

X: average output of all pixels, ΔX : difference between X and maximum or minimum output

Block diagram



Spectral response (typical example)



KMPDB0230EC



^{*5:} Voltage difference with respect to Voffset

^{*6:} Photoresponse nonuniformity (PRNU) is the output nonuniformity that occurs when the entire photosensitive area is uniformly illuminated by light which is 50% of the saturation exposure level. PRNU is measured using 510 pixels excluding the pixels at both ends, and is defined as follows: $PRNU = \Delta X/X \times 100$ (%)

^{*7:} Measured with a tungsten lamp of 2856 K

Resolution

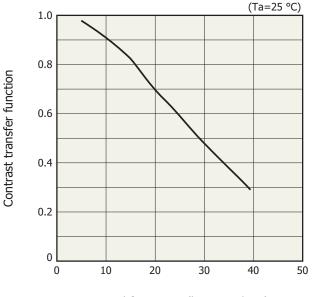
CTF: contrast transfer function

$$CTF = \frac{Vwo - VBO}{Vw - VB}$$

Vwo: output white level VBO: output black level

 \mbox{Vw} : output white level (when input pattern pulse width is wide) \mbox{VB} : output black level (when input pattern pulse width is wide)

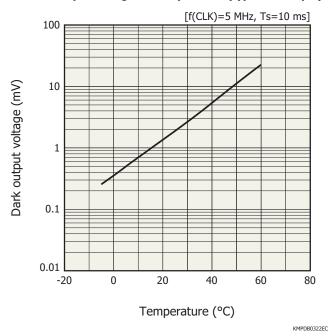
Contrast transfer function vs. spatial frequency (typical example)



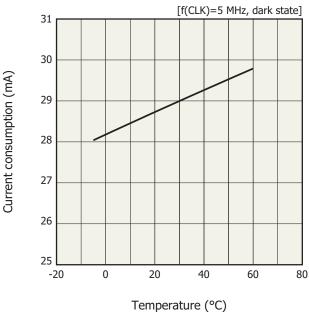
Spatial frequency (line pairs/mm)

KMPDB0321EC

► Dark output voltage vs. temperature (typical example)



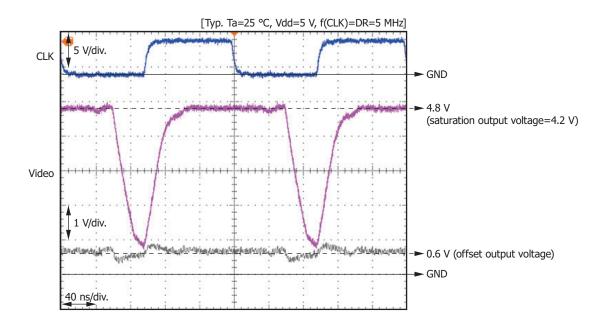
Current consumption vs. temperature (typical example)



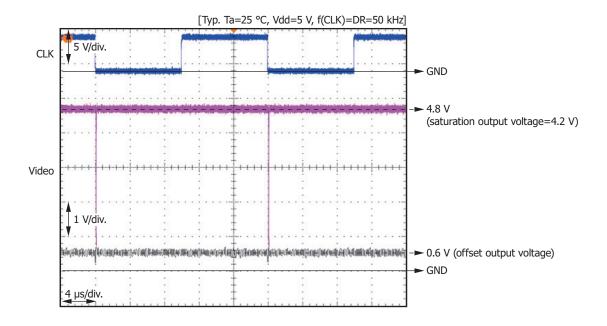
KMPDB0323EC

- Output waveform of one element

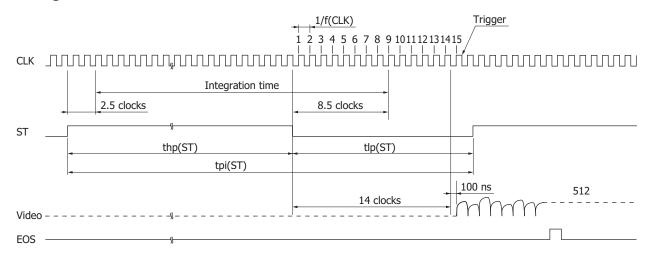
■ f(CLK)=DR=5 MHz

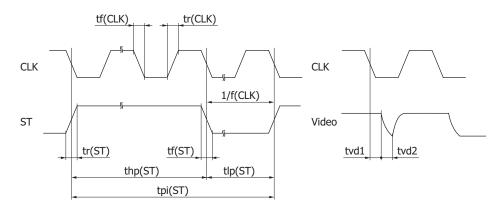


■ f(CLK)=DR=50 kHz



- Timing chart





KMPDC0166EF

| Parameter | Symbol | Min. | Тур. | Max. | Unit |
|---------------------------------|------------------|------------|------|--------|------|
| Start pulse cycle | tpi(ST) | 530/f(CLK) | - | 1100 m | S |
| Start pulse high period | thp(ST) | 8/f(CLK) | - | 1000 m | S |
| Start pulse low period | tlp(ST) | 15/f(CLK) | - | 100 m | S |
| Start pulse rise and fall times | tr(ST), tf(ST) | 0 | 20 | 30 | ns |
| Clock pulse duty ratio | - | 45 | 50 | 55 | % |
| Clock pulse rise and fall times | tr(CLK), tf(CLK) | 0 | 20 | 30 | ns |
| Video delay time 1 | tvd1 | 32 | 40 | 48 | ns |
| Video delay time 2 | tvd2 | 40 | 50 | 60 | ns |

Note: The internal timing circuit starts operating at the rise of CLK pulse immediately after ST pulse sets to low.

The integration time equals the high period of ST pulse plus 6 CLK cycles.

The output from 1st pixel appears 14 clocks plus 100 ns after the falling edge of ST pulse.

The EOS pulse is output 39 ns after the falling edge of CLK pulse.

The output voltage after reading the last pixel (512 pixels) is indefinite.

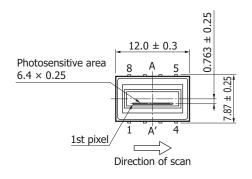
The integration time can be changed by changing the high-to-low ratio of ST pulses.

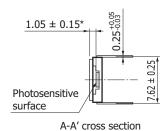
Start pulse setting example (for setting the start pulse cycle to a minimum and the integration time to a maximum) Start pulse high period=515/f(CLK), Start pulse low period=15/f(CLK)



Dimensional outlines (unit: mm)

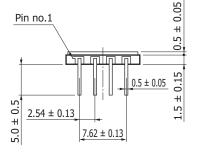
S9227-03





* Distance from upper surface of window to photosensitive surface

KMPDA0173EG

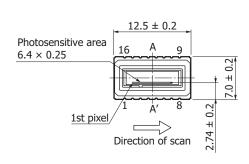


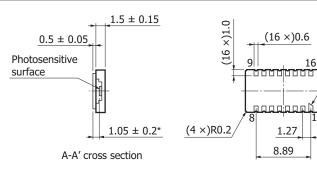
| Pin no. | Symbol | I/O | Pin name |
|---------|--------|-----|----------------|
| 1 | GND | | Ground |
| 2 | NC | | No connection |
| 3 | NC | | No connection |
| 4 | Vdd | I | Supply voltage |
| 5 | Video | 0 | Video signal*8 |
| 6 | EOS | 0 | End of scan |
| 7 | ST | I | Start pulse |
| 8 | CLK | I | Clock pulse |

*8: Connect a buffer amplifier for impedance conversion to the video output terminal so as to minimize the current flow. As the buffer amplifier, use a high input impedance operational amplifier with JFET or CMOS input.

Note: Leave the "NC'" terminals open and do not connect them to GND.

S9227-04





* Distance from upper surface of window to photosensitive surface

KMPDA0281ED

Index mark

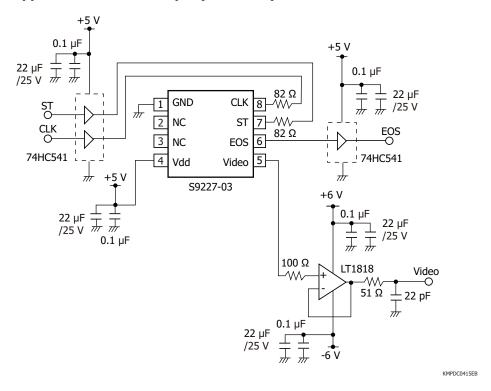
| Pin no. | Symbol | I/O | Pin name | Pin no. | Symbol | I/O | Pin name |
|---------|--------|-----|----------------|---------|--------|-----|----------------|
| 1 | NC | | No connection | 9 | NC | | No connection |
| 2 | NC | | No connection | 10 | NC | | No connection |
| 3 | GND | | Ground | 11 | Video | 0 | Video signal*8 |
| 4 | NC | | No connection | 12 | EOS | 0 | End of scan |
| 5 | NC | | No connection | 13 | ST | I | Start pulse |
| 6 | Vdd | I | Supply voltage | 14 | CLK | I | Clock pulse |
| 7 | NC | | No connection | 15 | NC | | No connection |
| 8 | NC | | No connection | 16 | NC | | No connection |

^{*8:} Connect a buffer amplifier for impedance conversion to the video output terminal so as to minimize the current flow. As the buffer amplifier, use a high input impedance operational amplifier with JFET or CMOS input.

Note: Leave the "NC" terminals open and do not connect them to GND.

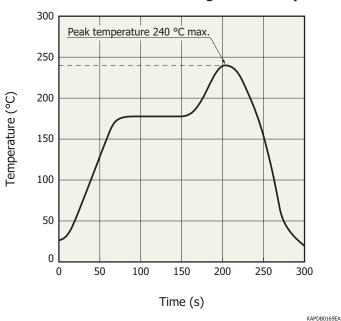


- Application circuit example (S9227-03)*9



*9: The S9227-04 has a different pin connections, but uses the same circuit.

Recommended reflow soldering conditions (S9227-04)



- This product (S9227-04) supports lead-free soldering. After unpacking, store it in an environment at a temperature of 30 °C or less and a humidity of 60% or less, and perform soldering within 24 hours.
- The effect that the product receives during reflow soldering varies depending on the circuit board and reflow oven that are used. Before actual reflow soldering, check for any problems by testing out the reflow soldering methods in advance.
- · A sudden temperature rise and cooling may be the cause of trouble, so make sure that the temperature change is within 4 °C per second.
- The bonding portion between the ceramic base and the glass may discolor after reflow soldering, but this has no adverse effects on the hermetic sealing of the product.



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Precautions

(1) Electrostatic countermeasures

This device has a built-in protection circuit against static electrical charges. However, to prevent destroying the device with electrostatic charges, take countermeasures such as grounding yourself, the workbench and tools to prevent static discharges. Also protect this device from surge voltages which might be caused by peripheral equipment.

(2) Light input window

If the incident window is contaminated or scratched, the output uniformity will deteriorate considerably, so care should be taken in handling the window. Avoid touching it with bare hands.

The window surface should be cleaned before using the device. If dry cloth or dry cotton swab is used to rub the window surface, static electricity may be generated, and therefore this practice should be avoided. Use soft cloth, cotton swab or soft paper moistened with ethyl alcohol to wipe off dirt and foreign matter on the window surface.

(3) Soldering

To prevent damaging the device during soldering, take precautions to prevent excessive soldering temperatures and times. Soldering should be performed within 5 seconds at a soldering temperature below 260 °C.

(4) Operating and storage environments

Handle the device within the temperature range specified in the absolute maximum ratings. Operating or storing the device at an excessively high temperature and humidity may cause variations in performance characteristics and must be avoided.

(5) UV exposure

This product is not designed to prevent deterioration of characteristics caused by UV exposure, so do not expose it to UV light.

Related information

www.hamamatsu.com/sp/ssd/doc_en.html

- Precautions
- Disclaimer
- · Image sensors/Precautions
- Surface mount type products/Precautions

Information described in this material is current as of February 2020.

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